G3R160MT17J
1700 V 160 mΩ SiC MOSFET

Silicon Carbide MOSFET
N-Channel Enhancement Mode

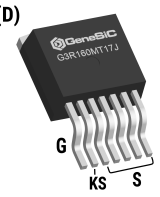
V_{DS}	=	1700 V
$R_{DS(ON)(Typ.)}$	=	160 mΩ
I_D (T_C = 100°C)	=	15 A

Features

- G3R™ Technology - +15 V / -5 V Gate Drive
- Superior Q_G x $R_{DS(ON)}$ Figure of Merit
- Low Capacitances and Low Gate Charge
- High V_{th} for Increased System Stability
- Fast and Reliable Body Diode
- High Avalanche and Short Circuit Ruggedness
- Low Conduction Losses at High Temperatures
- Optimized Package with Separate Driver Source Pin

Package

Case(D)



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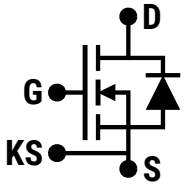


D = Drain
G = Gate
S = Source
KS = Kelvin Source

RoHS

REACH

Advantages

- Increased Power Density for Compact System
- High Frequency Switching
- Reduced Losses for Higher System Efficiency
- Minimized Gate Ringing
- Improved Thermal Capability
- Superior Cost-Performance Index
- Ease of Paralleing without Thermal Runaway
- Simple to Drive

Applications

- Solar String Inverter
- Solar Central Inverter
- Uninterruptible Power Supply (UPS)
- Switched Mode Power Supply (SMPS)
- Battery Charging
- Auxiliary Power Supply
- High Voltage Converter
- Pulsed Power

Absolute Maximum Ratings (At T_C = 25°C Unless Otherwise Stated)

Parameter	Symbol	Conditions	Values	Unit	Note
Drain-Source Voltage	$V_{DS(max)}$	V_{GS} = -5 V, I_D = 100 µA	1700	V	
Gate-Source Voltage (Dynamic)	$V_{GS(max)}$		-10 / +20	V	
Gate-Source Voltage (Static)	$V_{GS(op)}$	Recommended Operation	-5 / +15	V	
Continuous Forward Current	I_D	T_C = 25°C, V_{GS} = -5 / +15 V T_C = 100°C, V_{GS} = -5 / +15 V T_C = 135°C, V_{GS} = -5 / +15 V	22 15 11	A	Fig. 15
Pulsed Drain Current	$I_{D(pulse)}$	t_P ≤ 10µs, D ≤ 1%, Note 1	48	A	Fig. 14
Power Dissipation	P_D	T_C = 25°C	187	W	Fig. 16
Operating and Storage Temperature	T_j , T_{stg}		-55 to 175	°C	

Thermal/Package Characteristics

Parameter	Symbol	Conditions	Values			Unit	Note
			Min.	Typ.	Max.		
Thermal Resistance, Junction - Case	R_{thJC}			0.66	0.8	°C/W	Fig. 13
Weight	W_T			1.45		g	

Note 1: Pulse Width t_P Limited by $T_{j(max)}$

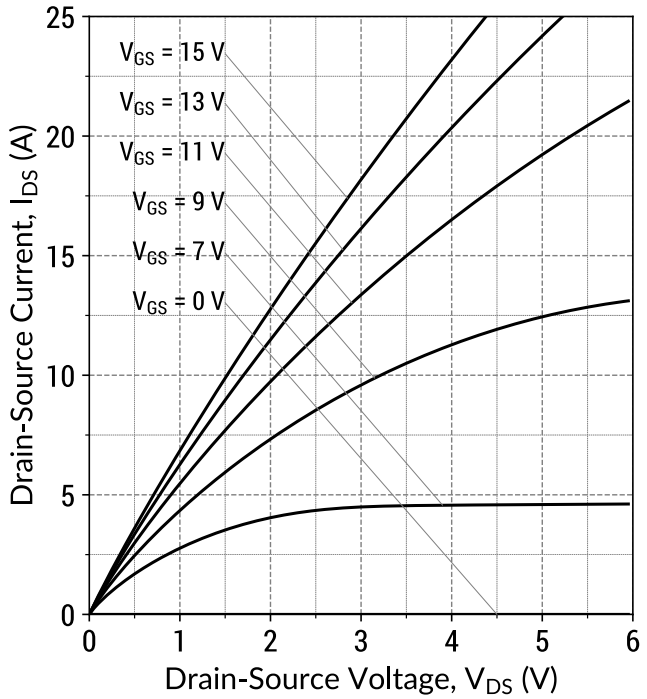
Electrical Characteristics (At T_C = 25°C Unless Otherwise Stated)

Parameter	Symbol	Conditions	Values			Unit	Note
			Min.	Typ.	Max.		
Drain-Source Breakdown Voltage	V_{DSS}	V_{GS} = -5 V, I_D = 100 µA	1700			V	
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = 1700 V, V_{GS} = -5 V		1		µA	
Gate Source Leakage Current	I_{GSS}	V_{DS} = 0 V, V_{GS} = 20 V V_{DS} = 0 V, V_{GS} = -10 V			100 -100	nA	
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS} = V_{GS}, I_D = 5.0 mA V_{DS} = V_{GS}, I_D = 5.0 mA, T_j = 175°C		2.7 2.05		V	Fig. 9
Transconductance	g_{fs}	V_{DS} = 10 V, I_D = 12 A V_{DS} = 10 V, I_D = 12 A, T_j = 175°C		5.4 6.1		S	Fig. 4
Drain-Source On-State Resistance	$R_{DS(ON)}$	V_{GS} = 15 V, I_D = 12 A V_{GS} = 15 V, I_D = 12 A, T_j = 175°C		160 311	208	mΩ	Fig. 5-8
Input Capacitance	C_{iss}	V_{DS} = 1000 V, V_{GS} = 0 V f = 1 MHz, V_{AC} = 25mV		1272		pF	Fig. 11
Output Capacitance	C_{oss}			32			
Reverse Transfer Capacitance	C_{rss}			4.8			
C_{oss} Stored Energy	E_{oss}			21		µJ	Fig. 12
C_{oss} Stored Charge	Q_{oss}			60		nC	
Gate-Source Charge	Q_{gs}	V_{DS} = 1000 V, V_{GS} = -5 / +15 V I_D = 12 A Per IEC607478-4		13		nC	Fig. 10
Gate-Drain Charge	Q_{gd}			24			
Total Gate Charge	Q_g			51			
Internal Gate Resistance	$R_{G(int)}$	f = 1 MHz, V_{AC} = 25 mV		2		Ω	

Reverse Diode Characteristics

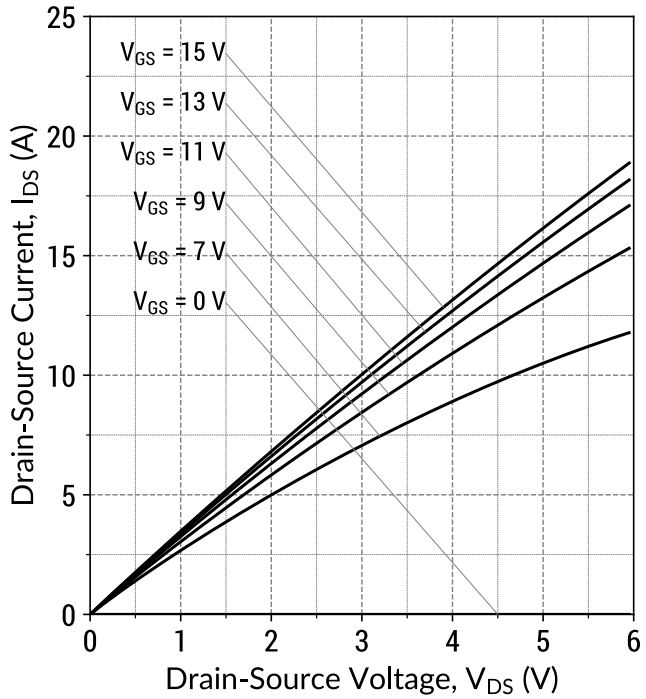
Parameter	Symbol	Conditions	Values			Unit	Note
			Min.	Typ.	Max.		
Diode Forward Voltage	V_{SD}	V_{GS} = -5 V, I_{SD} = 6 A V_{GS} = -5 V, I_{SD} = 6 A, T_j = 175°C		4.1 3.6		V	Fig. 17-18
Continuous Diode Forward Current	I_S	V_{GS} = -5 V, T_c = 100°C	17			A	
Diode Pulse Current	$I_{S(pulse)}$	V_{GS} = -5 V, Note 1		68		A	

Figure 1: Output Characteristics (T_j = 25°C)



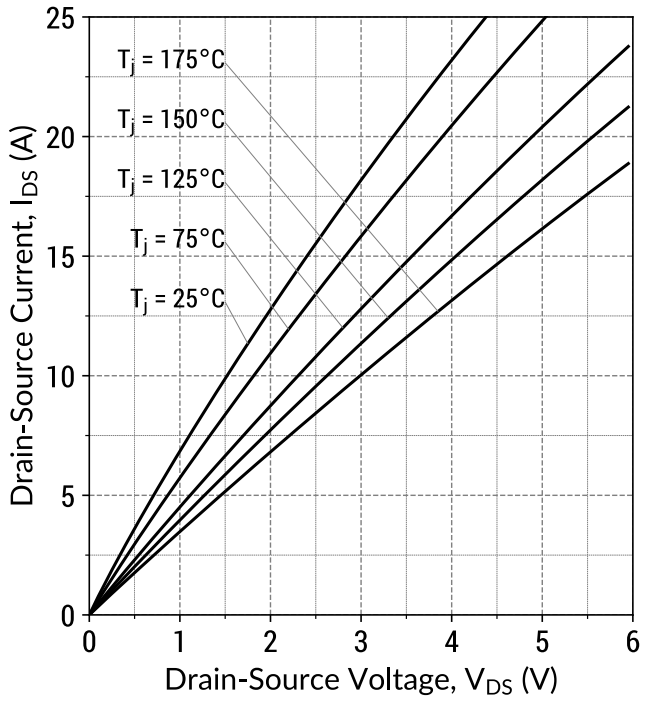
$I_D = f(V_{DS}, V_{GS})$; t_P = 250 µs

Figure 2: Output Characteristics (T_j = 175°C)



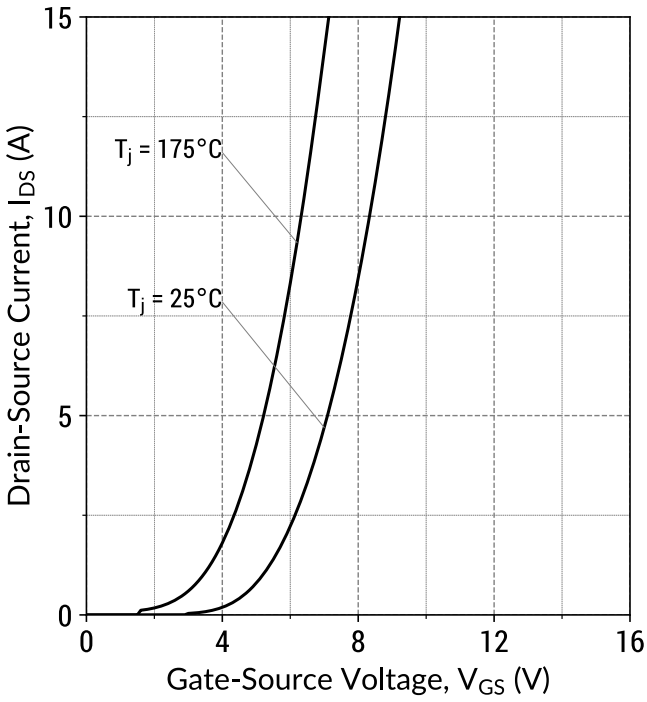
$I_D = f(V_{DS}, V_{GS})$; t_P = 250 µs

Figure 3: Output Characteristics (V_{GS} = 15 V)



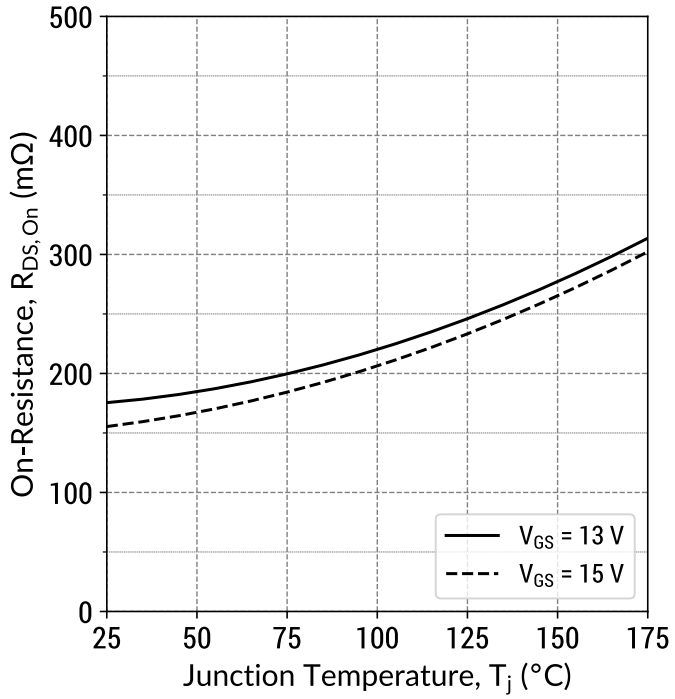
$I_D = f(V_{DS}, T_j)$; t_P = 250 µs

Figure 4: Transfer Characteristics (V_{DS} = 10 V)



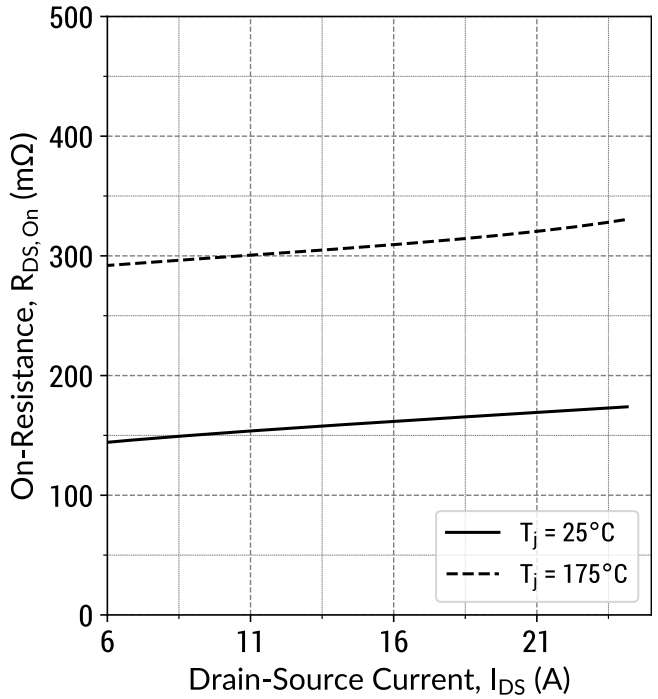
$I_D = f(V_{GS}, T_j)$; t_P = 100 µs

Figure 5: On-State Resistance v/s Temperature



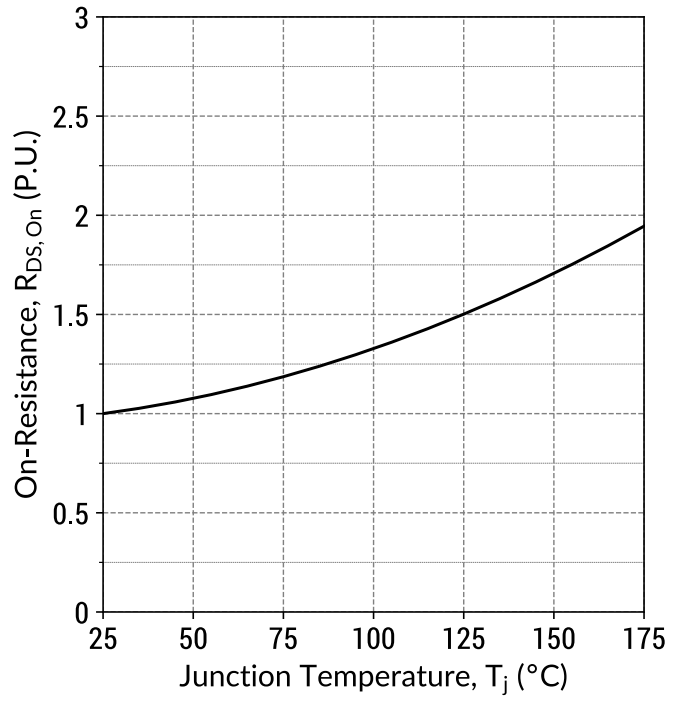
$R_{DS(ON)} = f(T_j, V_{GS})$; t_P = 250 µs; I_D = 12 A

Figure 6: On-State Resistance v/s Drain Current



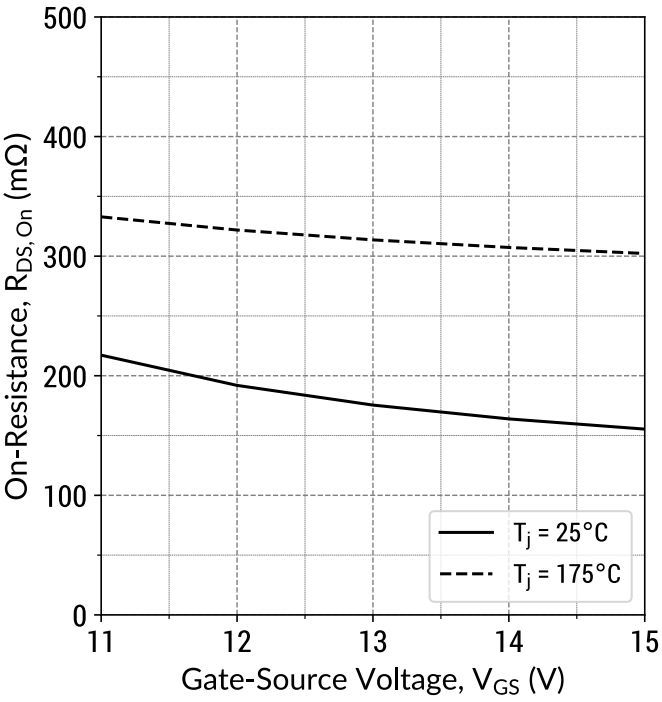
$R_{DS(ON)} = f(T_j, I_D)$; t_P = 250 µs; V_{GS} = 15 V

Figure 7: Normalized On-State Resistance v/s Temperature



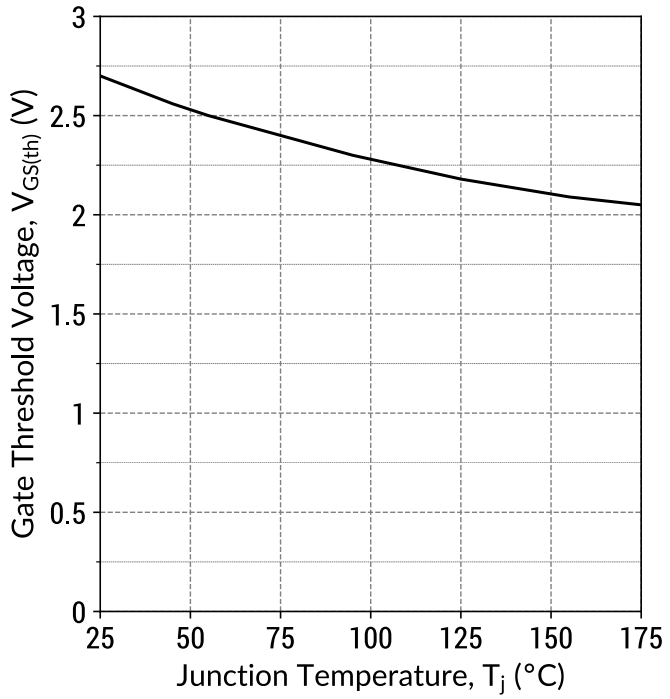
$R_{DS(ON)} = f(T_j)$; t_P = 250 µs; I_D = 12 A; V_{GS} = 15 V

Figure 8: On-State Resistance v/s Gate Voltage



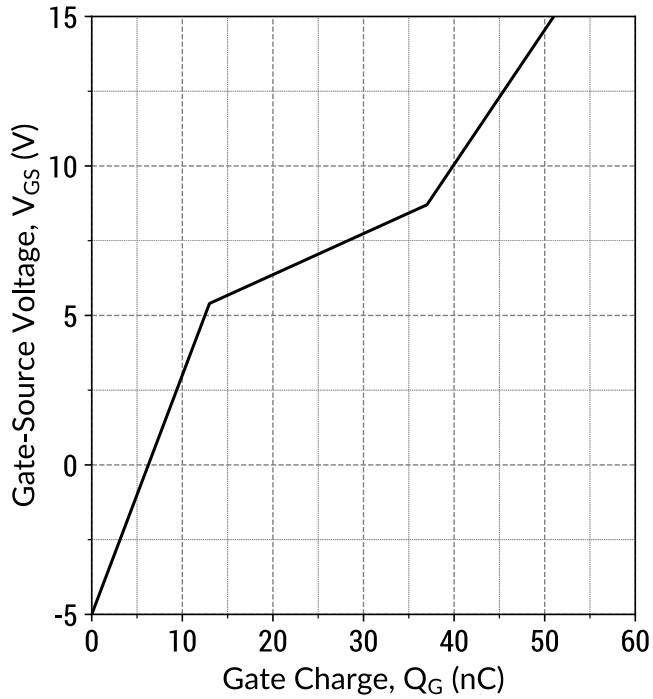
$R_{DS(ON)} = f(T_j, V_{GS})$; t_P = 250 µs; I_D = 12 A

Figure 9: Threshold Voltage Characteristics



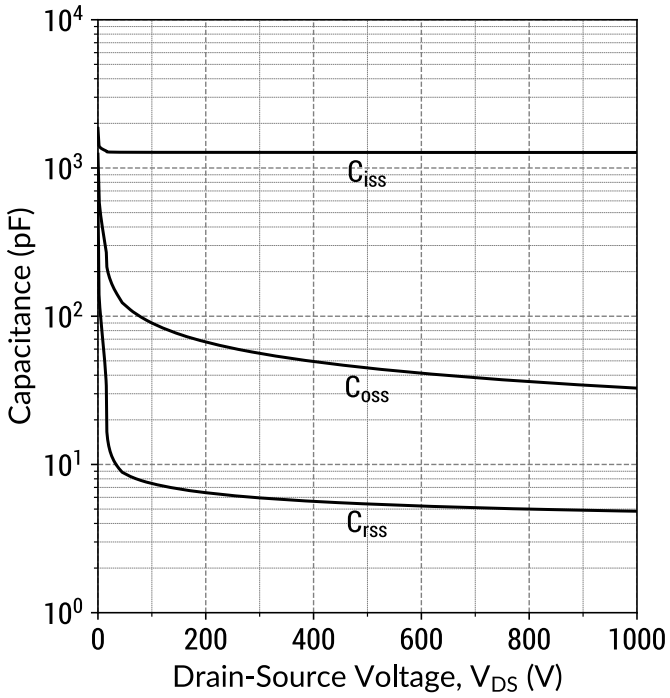
$V_{GS(th)} = f(T_j)$; $V_{DS} = V_{GS}$; $I_D = 5.0$ mA

Figure 10: Gate Charge Characteristics



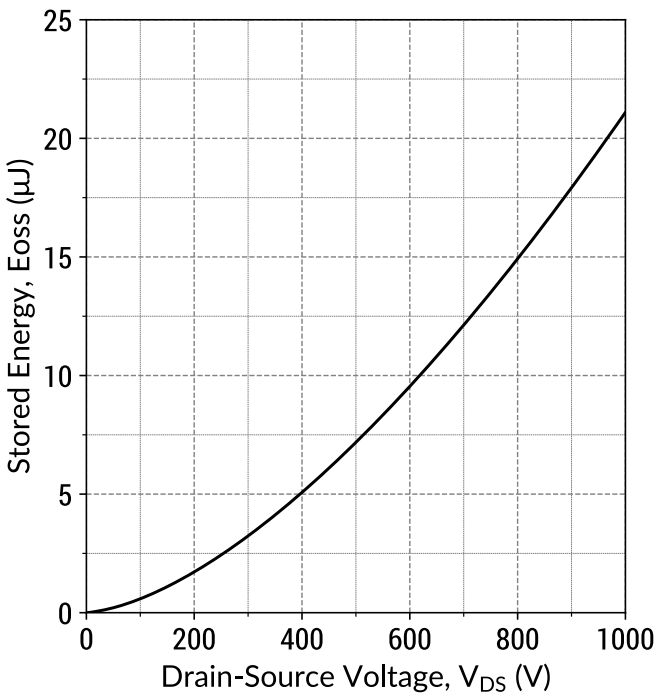
$I_D = 12$ A; $V_{DS} = 1000$ V; $T_c = 25$°C

Figure 11: Capacitance v/s Drain-Source Voltage



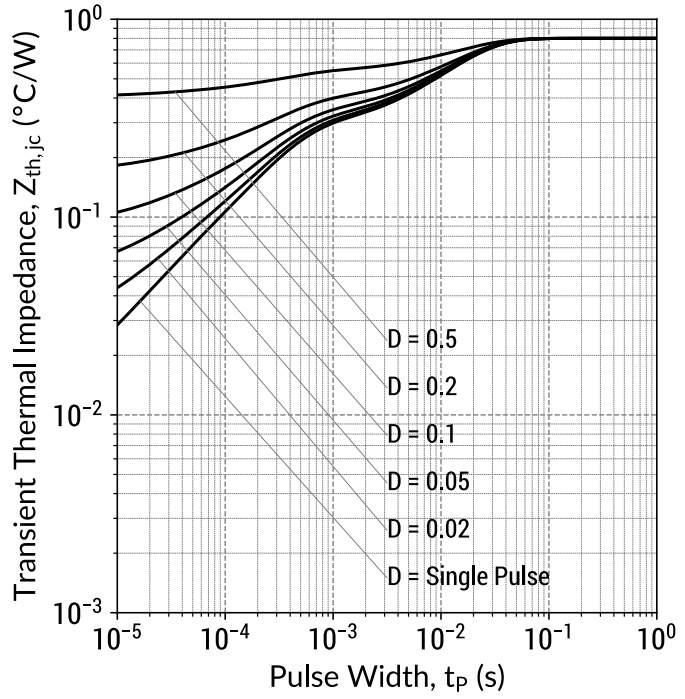
f = 1 MHz; V_{AC} = 25mV

Figure 12: Output Capacitor Stored Energy



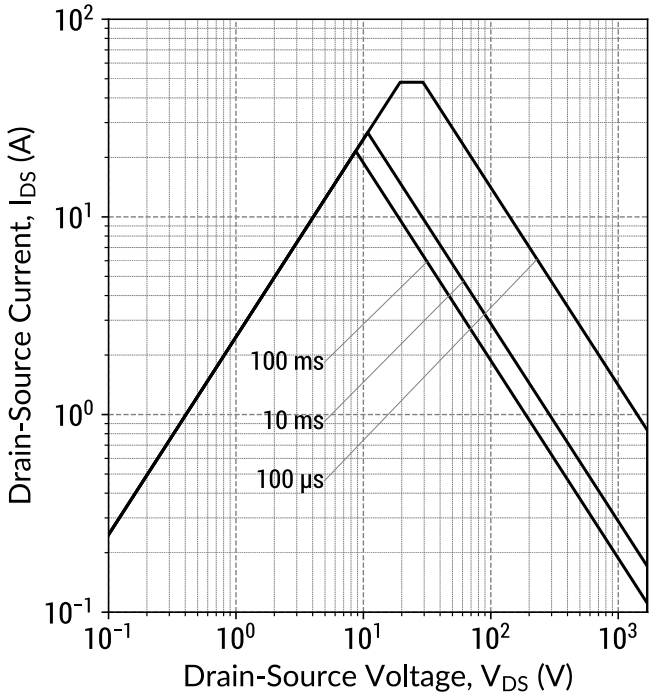
$E_{oss} = f(V_{DS})$

Figure 13: Transient Thermal Impedance



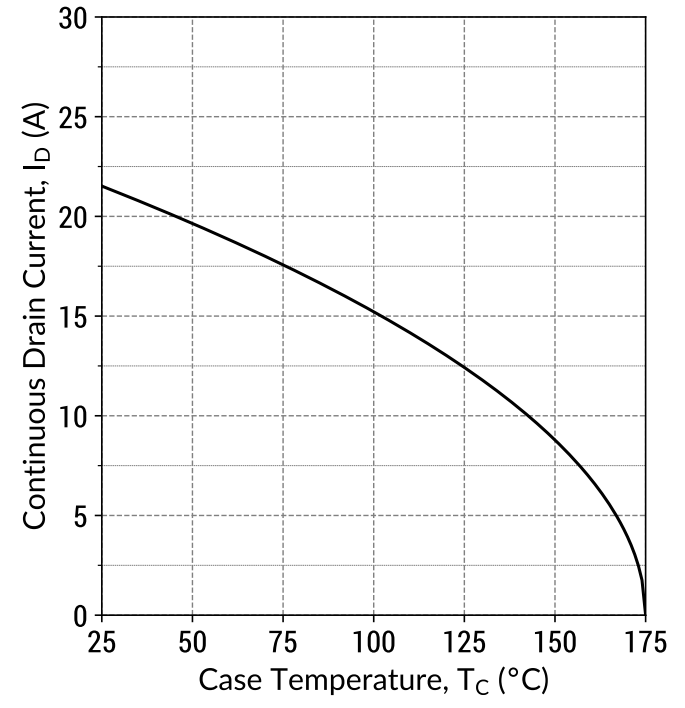
$Z_{th,jc} = f(t_P,D)$; $D = t_P/T$

Figure 14: Safe Operating Area (T_c = 25°C)



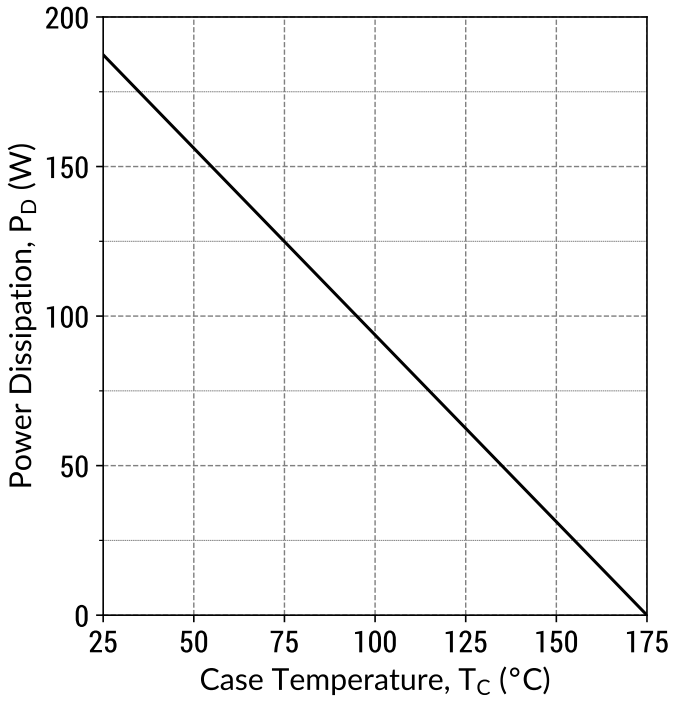
$I_D = f(V_{DS}, t_P)$; $T_j \leq 175°C$; $D = 0$

Figure 15: Current De-rating Curve



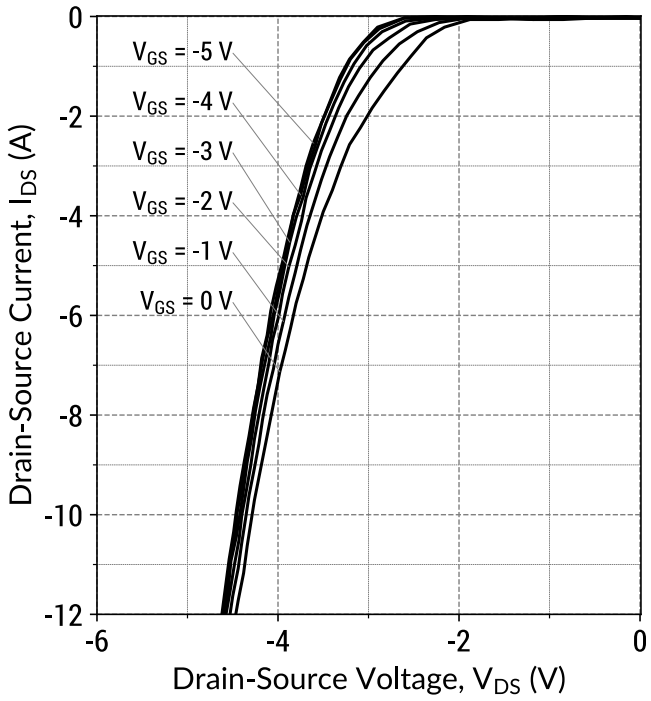
$I_D = f(T_C)$; $T_j \leq 175°C$

Figure 16: Power De-rating Curve



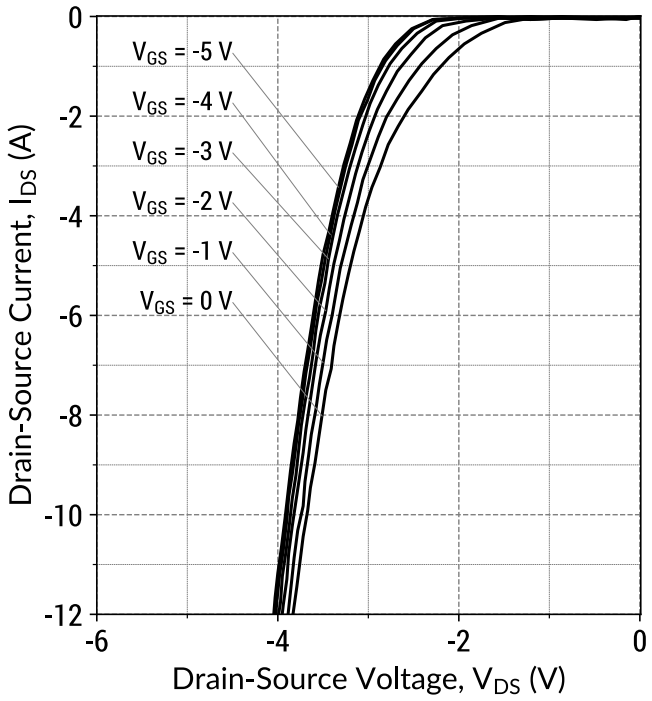
$P_D = f(T_C)$; $T_j \leq 175°C$

Figure 17: Body Diode Characteristics (T_j = 25°C)



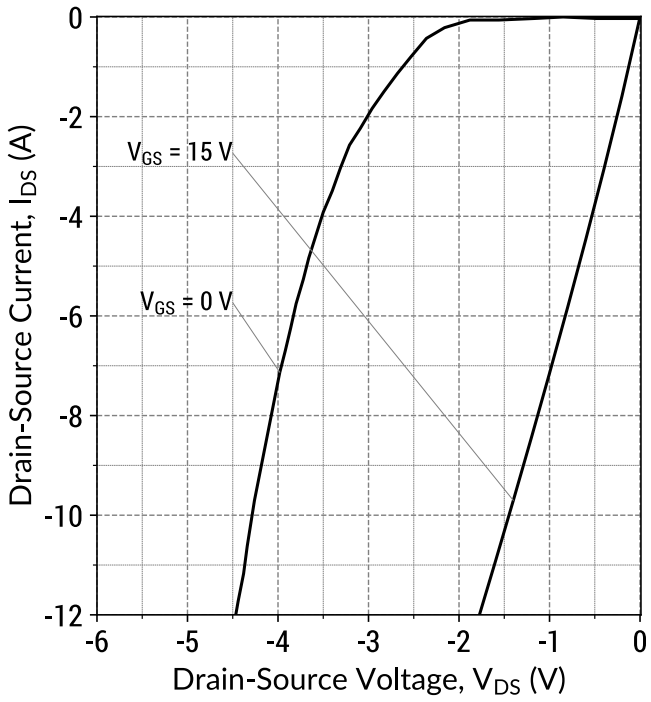
$I_D = f(V_{DS}, V_{GS})$; t_P = 250 µs

Figure 18: Body Diode Characteristics (T_j = 175°C)



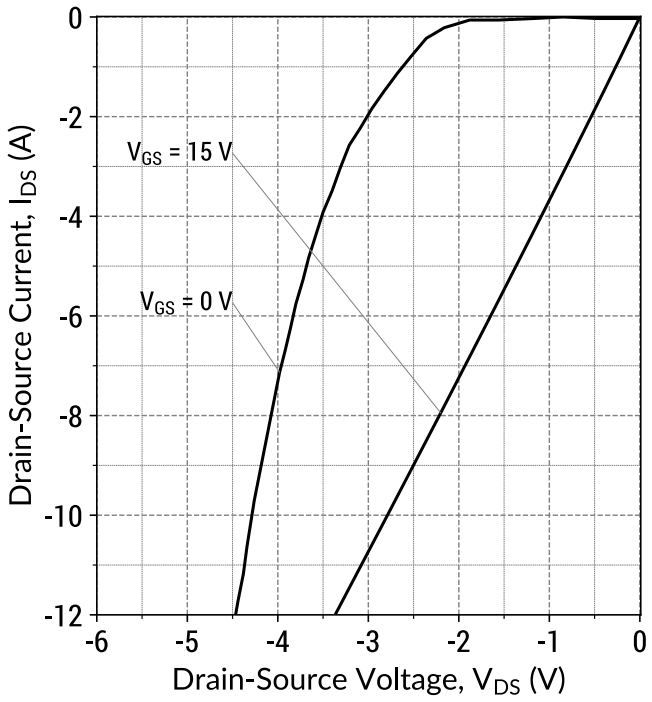
$I_D = f(V_{DS}, V_{GS})$; t_P = 250 µs

Figure 19: Third Quadrant Characteristics (T_j = 25°C)



$I_D = f(V_{DS}, V_{GS})$; t_P = 250 µs

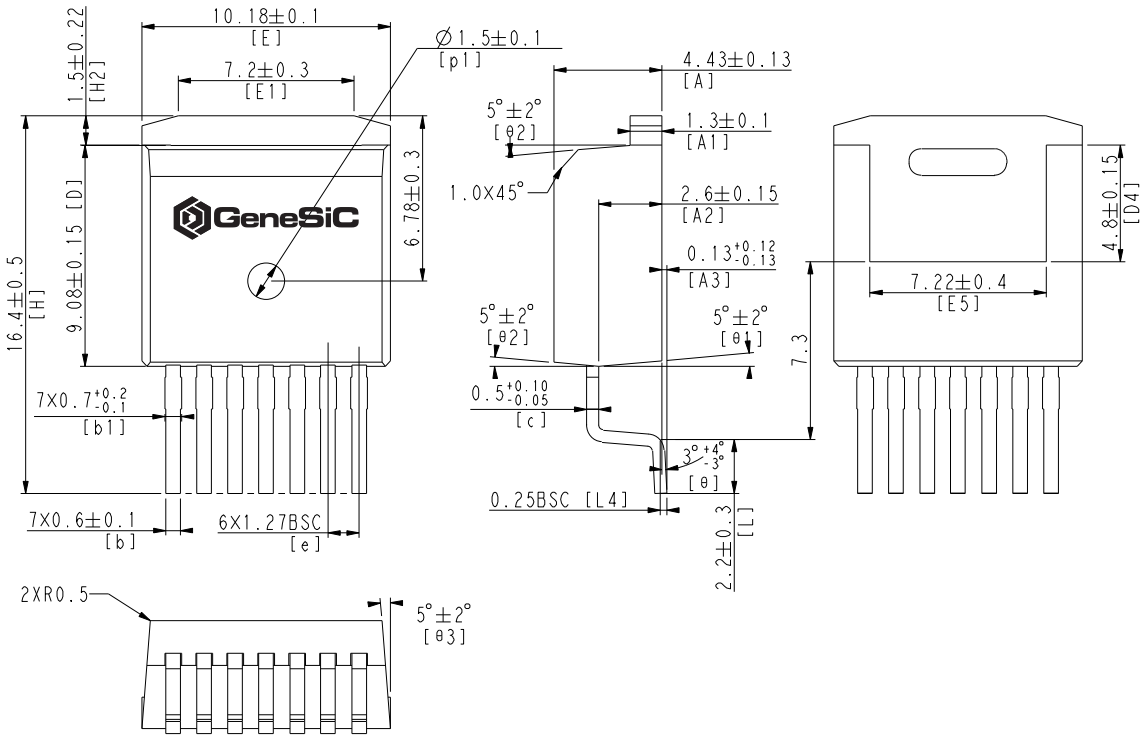
Figure 20: Third Quadrant Characteristics (T_j = 175°C)



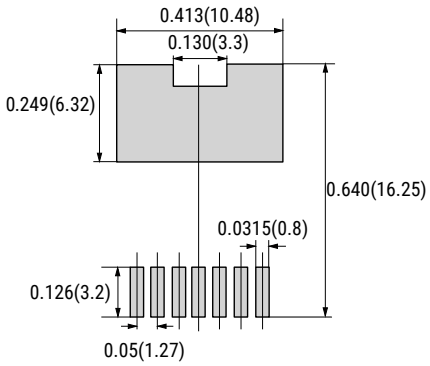
$I_D = f(V_{DS}, V_{GS})$; t_P = 250 µs

Package Dimensions

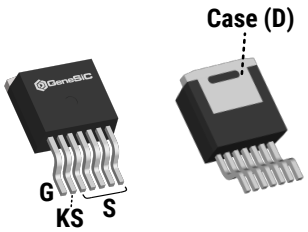
TO-263-7 Package Outline



Recommended Solder Pad Layout



Package View



NOTE

1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS.

Compliance

RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS 2), as adopted by EU member states on January 2, 2013 and amended on March 31, 2015 by EU Directive 2015/863. RoHS Declarations for this product can be obtained from your GeneSiC representative.

REACH Compliance

REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a GeneSiC representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

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Related Links

- SPICE Models: https://www.genesicsemi.com/sic-mosfet/G3R160MT17J/G3R160MT17J_SPICE.zip
- PLECS Models: https://www.genesicsemi.com/sic-mosfet/G3R160MT17J/G3R160MT17J_PLECS.zip
- CAD Models: https://www.genesicsemi.com/sic-mosfet/G3R160MT17J/G3R160MT17J_3D.zip
- Gate Driver Reference: https://www.genesicsemi.com/technical-support
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- Reliability: https://www.genesicsemi.com/reliability
- Compliance: https://www.genesicsemi.com/compliance
- Quality Manual: https://www.genesicsemi.com/quality

Revision History

Date	Revision	Comments	Supersedes
Sep. 28, 2020	Rev 2	Recommended Gate Voltage Changed from +20 V/-5 V to +15 V/-5 V,Rev 1	Rev 1
Jun. 2, 2020	Rev 1	Initial Release	

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